

IGBT Chip in NPT-technology

FEATURES:

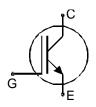
- 1200V NPT technology 200µm chip
- low turn-off losses
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

This chip is used for:

 power module BSM 50GD120DN2

Applications:

drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code	
SIGC81T120R2C	1200V	50A	9.08 X 8.98 mm ²	sawn on foil	Q67041- A4701-A003	

MECHANICAL PARAMETER:

Raster size	9.08 X 8.98				
Emitter pad size	8 x (2.6 x 1.78)				
Gate pad size	1.46 x 0.8				
Area total / active	81.5 / 63.5				
Thickness	200	μm			
Wafer size	150	mm			
Flat position	90	grd			
Max.possible chips per wafer	167 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500µm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t_p limited by T_{jmax}	I _{cpuls}	150	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I _C =3mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =50A	2.0	2.5	3.0	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=2mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V_{CE} =1200V , V_{GE} =0V			300	μΑ
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			300	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	Unit
Input capacitance	Ciss	V _{CE} =25V,	-	3300	-	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	500	-	
Reverse transfer capacitance	Crss	f=1MHz	-	220	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions ¹⁾	Value			Unit
			min.	typ.	max.	Unit
Turn-on delay time	t _{d(on)}	$T_{\rm j}$ =125°C	-	44	100	ns
Rise time	t _r	$V_{\rm CC} = 600 V$,	-	56	100	
Turn-off delay time	$t_{d(off)}$	I _C =50A, V _{GE} =+15/-15V,	-	380	500	
Fall time	t _f	R _G = 22Ω	-	70	100	

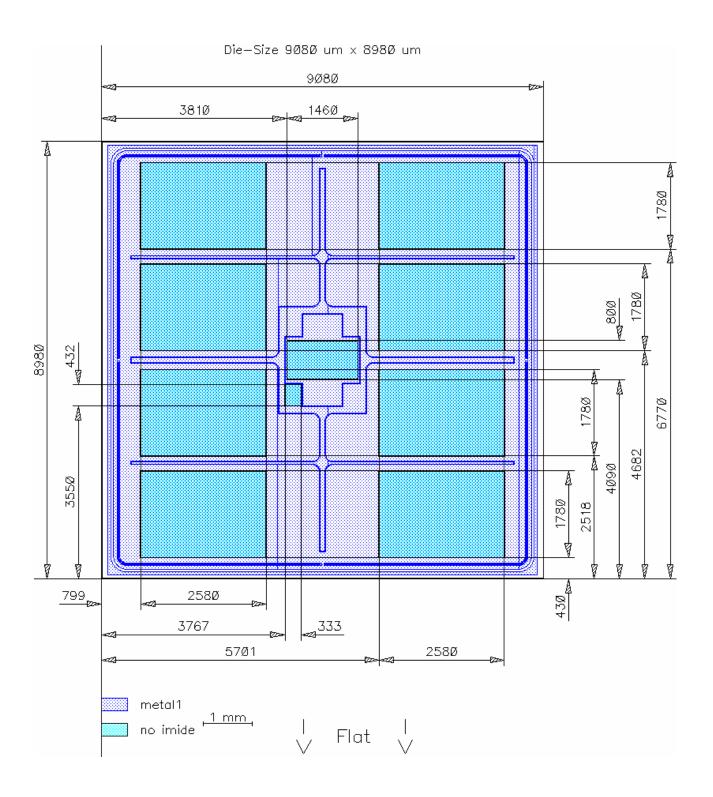
¹⁾ values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:





SIGC81T120R2C

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

BSM 50GD120DN2

ECONOPACK 2K

DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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